In Situ and Quantitative Tensile Study of Deformation Twinning in Submicron-Sized Mg Crystals Inside a Transmission Electron Microscope

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Quantitative tests inside the transmission electron microscope (TEM) provide in situ observation and stress-strain response simultaneously during sample deformation. Despite plentiful in situ TEM compression tests [1-4], rare tensile test which is more standard and informative, has been published in the literature so far, especially for HCP materials [5-7,10]. In this report, in situ tension and compression studies have been conducted quantitatively on submicron Mg single crystal samples, with a Hysitron PI95 TEM holder, for tensile loading in the c-direction and subsequently for compressive loading on the deformed sample. This in situ experiment documents the first direct observation of {10-12} twinning that instantly reorients the crystal by nearly 90°, as shown in Fig. 1, and de-twinning that gradually rotates the crystal to its original orientation. In c-axis tension, {10-12} twinning remains predominant deformation mechanism when sample size is reduced to D~200 nm, with the twinning stress far exceed that known for bulk Mg [8,9]. Different from compressive loading perpendicular to the c-axis, the tensile loading along the c-axis activates the {10-12} twinning at lower stresses [10] and accomplishes the twinning across the entire sample in one major strain burst (high twinning speed), as shown in Fig. 2. The compressive loading on the twinned sample can lead to a de-twinning and the twin boundary propagates from top to bottom gradually, accompanying a clearer work hardening than that in the c-axis tension [11].

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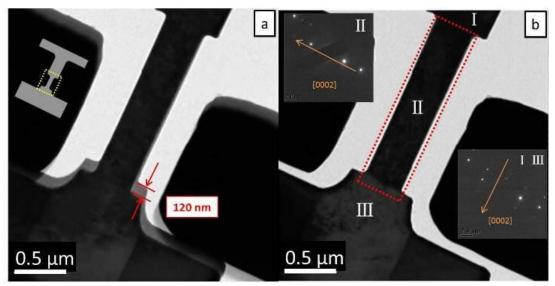


FIG. 1. (a) Bright-field TEM images (overlapped still frames, taken from the recorded movie) showing the sample before and after twinning, (b) Diffraction patterns showing the twin relationship.

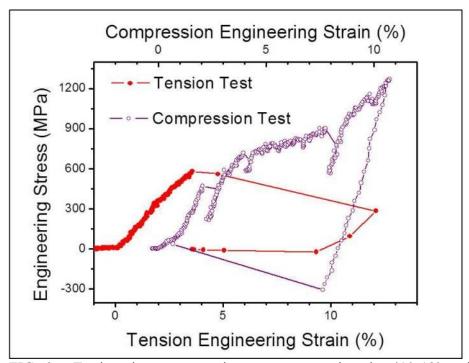


FIG. 2. Engineering stress-strain curves comparing the {10-12} twinning behavior activated by tension along the c-axis versus the de-twinning activated by compression perpendicular to the c-axis.